

IGBT Modules

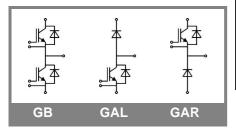
SKM 200GB123D SKM 200GAL123D SKM 200GAR123D

Features

- MOS input (voltage controlled)
- N channel, homogeneous Si
- · Low inductance case
- Very low tail current with low temperature dependence
- High short circuit capability, self limiting to 6 x I_{cnom}
- · Latch-up free
- Fast & soft inverse CAL diodes
- Isolated copper baseplate using DCB Direct Copper Bonding Technology
- Large clearance (13 mm) and creepage distances (20 mm)

Typical Applications

- AC inverter drives
- UPS



Absolute Maximum Ratings T _c = 25 °C, unless otherwise specified					
Symbol	Conditions		Values	Units	
IGBT					
V_{CES}	$T_{j} = 25 ^{\circ}\text{C}$ $T_{i} = 150 ^{\circ}\text{C}$		1200	V	
I _C	T _j = 150 °C	T _{case} = 25 °C	200	Α	
		T _{case} = 85 °C	180	Α	
I _{CRM}	I _{CRM} =2xI _{Cnom}		300	Α	
$V_{\rm GES}$			± 20	V	
t _{psc}	V_{CC} = 600 V; $V_{GE} \le 20$ V; $V_{CES} < 1200$ V	T _j = 125 °C	10	μs	
Inverse D	iode			•	
I _F	T _j = 150 °C	T_{case} = 25 °C	200	Α	
		T _{case} = 80 °C	130	Α	
I_{FRM}	I _{FRM} =2xI _{Fnom}		300	Α	
I _{FSM}	t _p = 10 ms; sin.	T _j = 150 °C	1440	Α	
Freewhee	eling Diode			•	
I_{F}	T _j = 150 °C	T_{case} = 25 °C	260	Α	
		T _{case} = 80 °C	180	Α	
I _{FRM}	I _{FRM} =2xI _{Fnom}		400	Α	
I _{FSM}	t _p = 10 ms; sin.	T _j = 150 °C	1800	Α	
Module					
$I_{t(RMS)}$			500	Α	
T _{vj}			- 40 + 150 (125)	°C	
T _{stg}			- 40+ 125	°C	
V _{isol}	AC, 1 min.		2500	V	

Characteristics $T_c = 25$ °C, unless otherwise specifie						ecified
Symbol	Conditions		min.	typ.	max.	Units
IGBT			•			•
$V_{GE(th)}$	$V_{GE} = V_{CE}$, $I_C = 6 \text{ mA}$		4,5	5,5	6,5	V
I _{CES}	$V_{GE} = 0 V, V_{CE} = V_{CES}$	T _j = 25 °C		0,1	0,3	mA
V_{CE0}		T _i = 25 °C		1,4	1,6	V
		T _j = 125 °C		1,6	1,8	V
r _{CE}	V _{GE} = 15 V	T _i = 25°C		7,33	9,33	mΩ
		$T_{j} = 125^{\circ}C$		10	12,66	mΩ
V _{CE(sat)}	I _{Cnom} = 150 A, V _{GE} = 15 V	T _j = °C _{chiplev} .		2,5	3	V
C _{ies}				10	13	nF
C _{oes}	V_{CE} = 25, V_{GE} = 0 V	f = 1 MHz		1,5	2	nF
C _{res}				0,8	1,2	nF
Q_G	V _{GE} = -8V - +20V			1500		nC
R _{Gint}	T _j = °C			2,5		Ω
t _{d(on)}				220	400	ns
t_r	R_{Gon} = 5,6 Ω	$V_{CC} = 600V$		100	200	ns
E _{on}		I _C = 150A		24		mJ
$t_{d(off)}$	$R_{Goff} = 5.6 \Omega$	T _j = 125 °C		600	800	ns
t _f		$V_{GE} = -15V$		70	100	ns
E_{off}				17		mJ
R _{th(j-c)}	per IGBT				0,09	K/W



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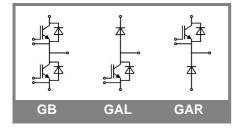
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Characte	ristics					
Symbol	Conditions	l	min.	typ.	max.	Units
Inverse D		·				·
$V_F = V_{EC}$	I_{Fnom} = 150 A; V_{GE} = 0 V			2	2,5	V
		$T_j = 125 ^{\circ}C_{\text{chiplev.}}$		1,8		V
V_{F0}		T _j = 25 °C		1,1	1,2	٧
		T _j = 125 °C				V
r _F		T _j = 25 °C		6	8,7	mΩ
		T _j = 125 °C				mΩ
I _{RRM}	I _F = 150 A	T _j = 125 °C		90		Α
Q_{rr}	di/dt = 1500 A/μs			8		μC
E _{rr}	$V_{GE} = -15 \text{ V}; V_{cc} = 600 \text{V}$			6,6		mJ
$R_{th(j-c)D}$	per diode				0,25	K/W
	eling Diode					
$V_F = V_{EC}$	I_{Fnom} = 200 A; V_{GE} = 0 V			2	2,5	V
		$T_j = 125 ^{\circ}C_{\text{chiplev.}}$ $T_j = 25 ^{\circ}C$		1,8		V
V_{F0}				1,1	1,2	V
		T _j = 125 °C				V
r _F		T _j = 25 °C		4,5	6,5	V
		T _j = 125 °C				V
I _{RRM}	I _F = 200 A	T _j = 125 °C		120		Α
Q _{rr}	di/dt = 2000 A/μs			11		μC
E _{rr}	$V_{GE} = 0 \text{ V}; V_{CC} = 600 \text{ V}$					mJ
$R_{th(j-c)FD}$	per diode				0,18	K/W
Module						_
L _{CE}				15	20	nH
R _{CC'+EE'}	res., terminal-chip	T _{case} = 25 °C		0,35		mΩ
		T _{case} = 125 °C		0,5		mΩ
R _{th(c-s)}	per module				0,038	K/W
M _s	to heat sink M6		3		5	Nm
M _t	to terminals M6, M4		2,5		5	Nm
w					325	g

This is an electrostatic discharge sensitive device (ESDS), international standard IEC 60747-1, Chapter IX.

This technical information specifies semiconductor devices but promises no characteristics. No warranty or guarantee expressed or implied is made regarding delivery, performance or suitability.





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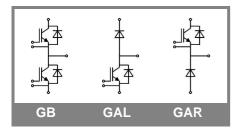
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Z _{th} Symbol	Conditions	Values	Units
Z _{th/i a}			·
Z _{Ri}	i = 1	59	mk/W
Ri	i = 2	23	mk/W
R _i R _i	i = 3	6,8	mk/W
R _i	i = 4	1,2	mk/W
tau _i	i = 1	0,03	s
tau _i	i = 2	0,0087	s
tau _i	i = 3	0,002	s
tau _i	i = 4	0,0002	s
Z R _i th(j-c)D			
R _i	i = 1	170	mk/W
R_i	i = 2	66	mk/W
R_i	i = 3	12	mk/W
R_i	i = 4	2	mk/W
tau _i	i = 1	0,0348	s
tau _i	i = 2	0,0072	s
tau _i	i = 3	0,077	s
tau _i	i = 4	0,0002	s

